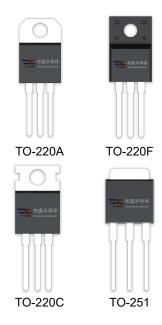
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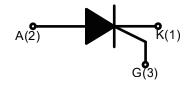
### **DESCRIPTION:**

With high ability to withstand the shock loading of large current, BT151U-500C series of silicon controlled rectifiers provide high dv/dt rate with strong resistance to electromagnetic interference. They are especially recommended for use on solid state relay, motorcycle, power charger, T-tools etc.



### **MAIN FEATURES**

| Symbol                              | Value   | Symbol   |
|-------------------------------------|---------|----------|
| V <sub>DRM</sub> / V <sub>RRM</sub> | 650/800 | <b>V</b> |
| I <sub>T(RMS)</sub>                 | 12      | Α        |
| I <sub>GT</sub>                     | ≤15     | mA       |



#### **ABSOLUTE MAXIMUM RATINGS**

| Parameter   |  | Symbol              | Value     | Unit          |
|---|--|---------------------|-----------|---------------|
| Storage junction temperature range                          |  | T <sub>stg</sub>    | -40 - 150 | ${\mathbb C}$ |
| Operating junction temperature range                        |  | Tj                  | -40 - 150 | $^{\circ}$    |
| Repetitive peak off-state voltage (T <sub>j</sub> =25°ℂ)    |  | $V_{DRM}$           | 650/800   | V             |
| Repetitive peak reverse voltage (T <sub>j</sub> =25℃)       |  | V <sub>RRM</sub>    | 650/800   | V             |
| RMS on-state current  | TO-251/<br>TO-220C/<br>TO-220A (Non-Ins)<br>(T <sub>C</sub> =130℃)<br>TO-220A (Ins)/<br>TO-220F (Ins) (T <sub>C</sub> =125℃) | I <sub>T(RMS)</sub> | 12        | А             |
| Non repetitive surge peak on-state current (F=50Hz tp=10ms) |  | Ітѕм                | 120       | А             |

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| Non repetitive surge peak on-state current (F=60Hz tp=8.3ms)       | I <sub>TSM</sub>   | 132 | А                |
|--|--------------------|-----|------------------|
| I <sup>2</sup> t value for fusing (tp=10ms)                        | l <sup>2</sup> t   | 72  | A <sup>2</sup> s |
| Repetitive rate of rise of on-state current $(I_G=2\times I_{GT})$ | dl⊤/dt             | 50  | A/µs             |
| Peak gate current  | I <sub>GM</sub>    | 2   | Α                |
| Peak gate power  | P <sub>GM</sub>    | 5   | W                |
| Average gate power dissipation                                     | P <sub>G(AV)</sub> | 0.5 | W                |

## **ELECTRICAL CHARACTERISTICS** (T<sub>j</sub>=25°C unless otherwise specified)

| Symbol           | Test Condition   | Value |      |      | llnit |
|------------------|--|-------|------|------|-------|
|                  | rest Condition   | MIN.  | TYP. | MAX. | Unit  |
| I <sub>GT</sub>  | V -40V D -220  | -     | 4    | 15   | mA    |
| V <sub>GT</sub>  | $V_D=12V R_L=33\Omega$   | -     | 0.75 | 1.5  | V     |
| V <sub>GD</sub>  | $V_D=V_{DRM}T_j=150^{\circ}C$ RL=3.3K $\Omega$                   | 0.2   | -    | -    | V     |
| IL               | I <sub>G</sub> =1.2I <sub>GT</sub>                               | -     | 12   | 40   | mA    |
| lн               | I⊤=500mA   | -     | 12   | 30   | mA    |
| dV/dt            | V <sub>D</sub> =540V Gate Open T <sub>j</sub> =150℃              | 50    | -    | -    | V/µs  |
| dV/dt            | V <sub>D</sub> =436V Gate Open T <sub>j</sub> =150℃              | 80    | -    | -    | V/µs  |
| ton              | I <sub>GT</sub> =20mA I <sub>A</sub> =100mA I <sub>R</sub> =10mA | -     | 2    | -    | μs    |
| t <sub>off</sub> | T <sub>j</sub> =25℃  | -     | 30   | -    | μs    |
| R <sub>d</sub>   | Dynamic resistance T <sub>j</sub> =125℃                          | -     | -    | 35   | mΩ    |

### **STATIC CHARACTERISTICS**

| Symbol           | Parameter   |                     | Value(MAX) | Unit |
|------------------|---|---------------------|------------|------|
| V <sub>TM</sub>  | I <sub>TM</sub> =23A tp=380μs                                     | T <sub>j</sub> =25℃ | 1.6        | V    |
| IDRM             | V <sub>D</sub> =V <sub>DRM</sub> V <sub>R</sub> =V <sub>RRM</sub> | Tj=25℃              | 10         | μA   |
| I <sub>RRM</sub> |   | Tj=150℃             | 1          | mA   |



# BT151U-500C/BT151U-650C/TN1215-600H

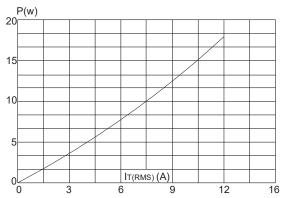
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## **THERMAL RESISTANCES**

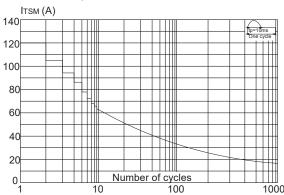
| Symbol                 | Parameter        |  | Value | Unit          |
|------------------------|------------------|--|-------|---------------|
| R <sub>th(j-c)</sub> J | Junction to case | TO-251/<br>TO-220C/<br>TO-220A (Non-Ins) | 1.3   | - ℃ <b>/W</b> |
|                        |                  | TO-220A (Ins)                            | 1.6   |               |
|                        |                  | TO-220F (Ins)                            | 1.7   |               |



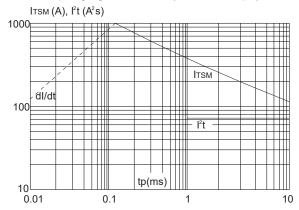
**FIG.1:** Maximum power dissipation versus RMS on-state current



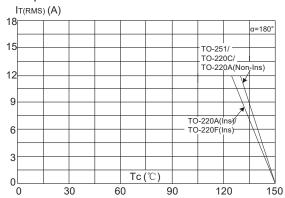
**FIG.3:** Surge peak on-state current versus number of cycles



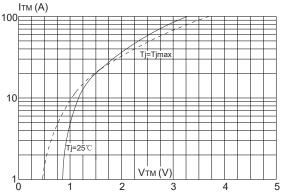
**FIG.5:** Non-repetitive surge peak on-state current for a sinusoidal pulse with width tp<10ms, and corresponging value of I²t (dI/dt < 50A/μs)



**FIG.2:** RMS on-state current versus case temperature



**FIG.4:** On-state characteristics (maximum values)



**FIG.6:** Relative variations of gate trigger current, holding current and latching current versus junction temperature

